

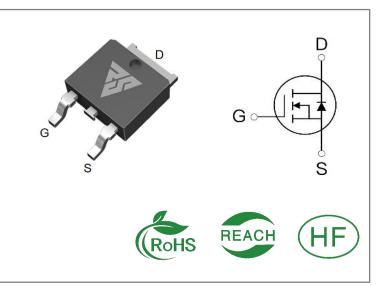
ID	R _{DS} (ON)(Typ)	VDSS
ЗA	7.3Ω	1200V

Applications:

- Switch Mode Power Supply(SMPS)
- Adapter & Charger
- AC-DC Switching Power Supply

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	ber Package Marking		Packing	Qty.	
RS3N120D	T0-252	RS3N120D	Tape&reel	2500 PCS	

Absolute Maximun Ratings Tc= 25° C unless otherwise specified

Symbol	Parameter	RS3N120D	Units
VDSS	Drain-to-Source Voltage	1200	V
ID	Continuous Drain Current TC=25℃	3	٨
IDM	Pulsed Drain Current (Note*1)	12	A
PD	Power Dissipation	96	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	65	mJ
	Maximum Temperature for Soldering		
TL TPKG	TL TPKG Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds		°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the" Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS3N120D	Units	Test Conditions
RθJC	Junction-to-Case	1.3	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\!C$
RθJA	Junction-to- Ambient	110		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	1200			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1	μA	VDS=1200V,VGS =0V
IGSS	Gate- to- Source Forward 100		- 4	VGS=30V ,VDS=0 V		
	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		7.3	8.5	Ω	VGS=10V,ID=1.5 A
VGS(TH)	Gate Threshold Voltage	3		5	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter		Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		40			
trise	Rise Time		10		6	VDS=600V ID=3A RG=25Ω
td(OFF)	Turn- OFF Delay Time		75		nS	
tfall	Fall Time		50			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
Ciss	Input Capacitance		650			VGS=0V	
Coss	Output Capacitance		65		pF	VDS=25V	
Crss	Reverse Transfer Capacitance		10			f=1.0MHz	
Qg	Total Gate Charge		27.5			VDS=960V	
Qgs	Gate- to- Source Charge		3		nC	ID=3A	
Qgd	Gate-to-Drain(" Miller") Charge		10.5			VGS=10V	

Source- Drain Diode Characteristics

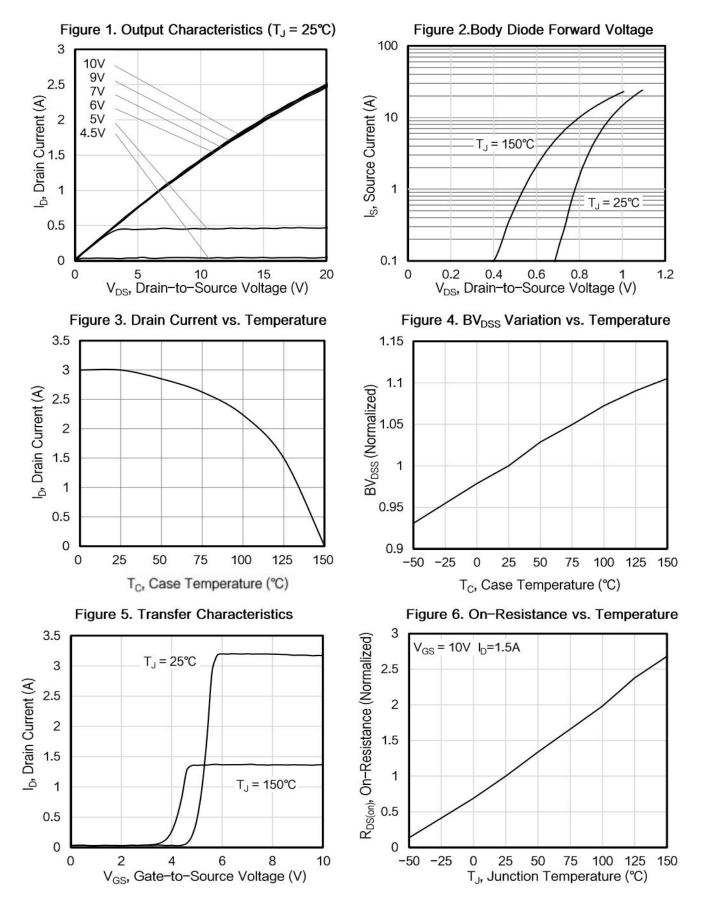
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			3	А	Integral pn- diode
ISM	Maximum Pulsed Current			12	А	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=1.5A,VGS=0V
trr	Reverse Recovery Time		1200		nS	VGS=0V
Qrr	Reverse Recovery Charge		5.2		μC	IS=3A,di/dt=100A /µs

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%



Typical Feature Curve



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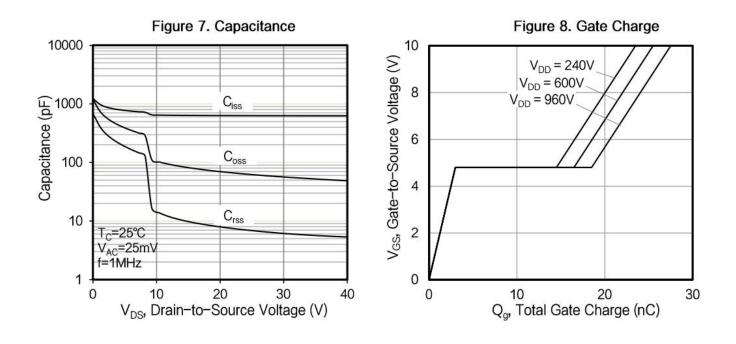
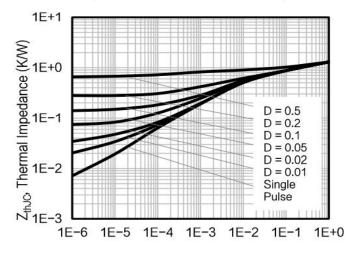


Figure 9. Transient Thermal Impedance



T_p, Pulse Width (s)



Test Circuits and Waveforms

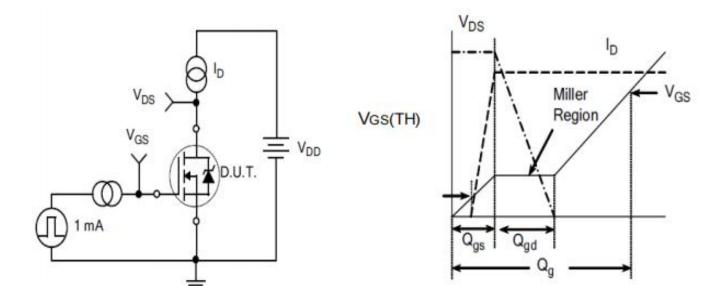
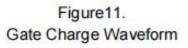


Figure10. Gate Charge Test Circuit



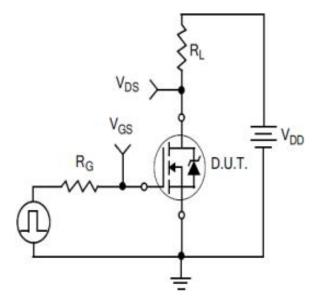


Figure12. Resistive Switching Test Circuit

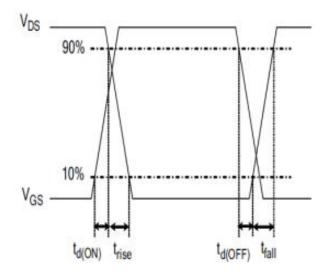
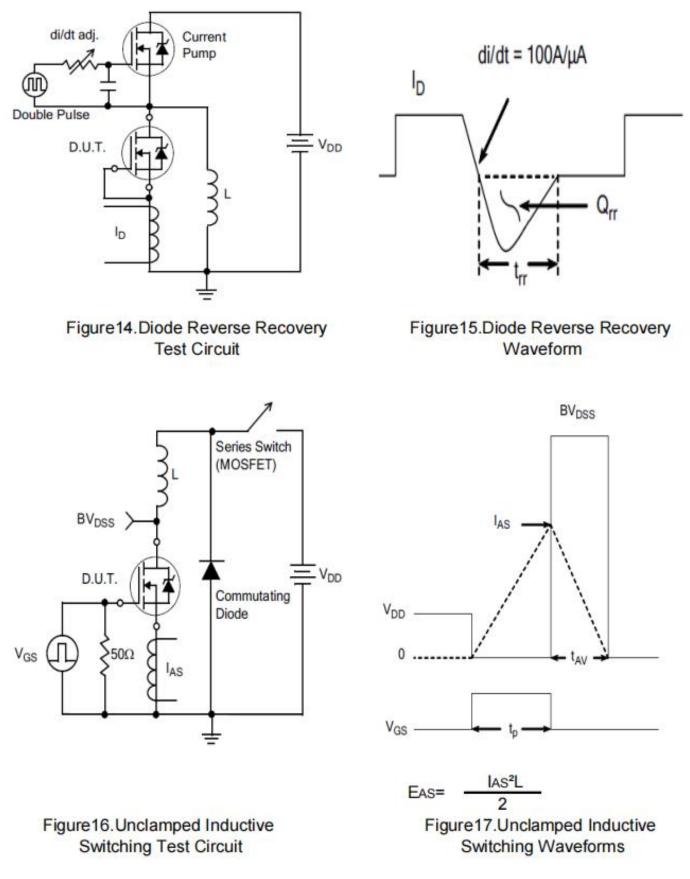


Figure13. Resistive Switching Waveforms

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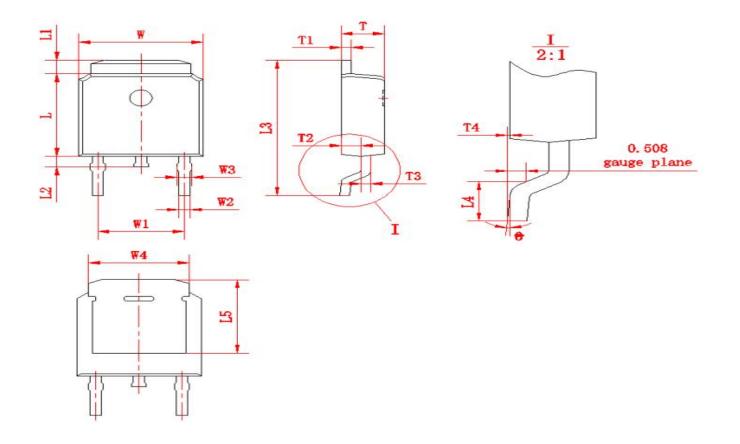


Test Circuits and Waveforms





Package outline drawing(TO-252 Unit: mm)



符号	尺寸		符号	尺寸		符号	尺寸	
<u>5</u> T	Min	Max	17.2	Min	Max	17.2	Min	Max
W	6.50	6.70	L1	0.80	1.20	T1	0.48	0.58
W1	1 (4.572)		L2	0.60	1.00	T2	0.95	1.15
W2	0.6	0.8	L3	9.70	10.30	Т3	0.48	0.58
W3	0.68	0.88	L4	1.30	1.70	T4	0.00	0.12
W4	(5	.3)	L5	(5.20)		0	0	8
L	6.00	6.20	Т	2.20	2.40			



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